One Cell Lithium-ion/Polymer Battery Protection IC

GENERAL DESCRIPTION

The XB6042 series product is a high integration solution for lithiumion/polymer battery protection. XB6042 series contains advanced power MOSFET, high-accuracy voltage detection circuits and delay circuits. XB6042 series is put into an DFN1X1x0.37-4 package and only one external component makes it an ideal solution in limited space of battery pack. XB6042 series has all the protection functions required in the battery application including overcharging, overdischarging, overcurrent and load short circuiting protection etc. The accurate overcharging detection voltage ensures safe and full utilization charging. The low standby current drains little current from the cell while in storage.

The device is not only targeted for digital cellular phones, but also for any other Li-Ion and Li-Poly battery-powered information appliances requiring long-term battery life.

- Protection of Battery Cell Reverse
 Connection without external load
- Integrate Advanced Power MOSFET with Equivalent of $44m\Omega$ R_{DS(ON)}
- DFN1X1x0.37-4 Package
- Low Overcharge Release Voltage
- Over-temperature Protection
- Overcharge Current Protection 0.4A
- Two-step Overcurrent Detection:
 -Overdischarge Current 0.4A
 -Load Short Circuiting
 - Charger Detection Function
- OV Battery Charging Function
- Delay Times are generated inside
- High-accuracy Voltage Detection
- Low Current Consumption
 - Operation Mode: 1.5µA Typ.
- RoHS Compliant and Lead (Pb) Free

APPLICATIONS

One-Cell Lithium-ion Battery Pack Lithium-Polymer Battery Pack Wearable Device Bluetooth Earphone

FEATURES

 Protection of Charger Reverse Connection

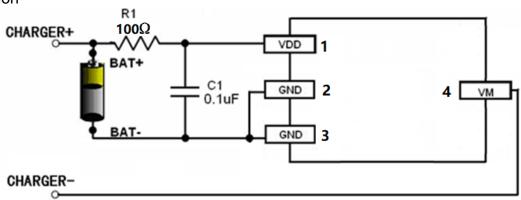


Figure 1. Typical Application Circuit

ORDERING INFORMATION

| PART NUMBER | Overcharge Detection Voltage [Vcu] (V) | Overcharge Release Voltage [VcL] (V) | Overdischarge Detection Voltage [VDL] (V) | Overdischarge Release Voltage [VDR] (V) | Power Down Current [Isd] (uA) | Diode Forward Voltage Vsd(V) ** | Top Mark |
|----------------|---|---|--|--|-------------------------------------|--|----------------|
| XB6042I2 | 4.30±50mV | 4.10±50mV | 2.8±100mV | 3.0±100mV | 1.0 | NA | |
| XB6042J2 | 4.425±50mV | 4.25±50mV | 2.8±100mV | 3.0±100mV | 1.0 | NA | |
| XB6042M2 | 4.475±50mV | 4.30±50mV | 2.8±100mV | 3.0±100mV | 1.0 | NA | |
| XB6042I2S | 4.30±50mV | 4.10±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | NA | |
| XB6042J2S | 4.425±50mV | 4.25±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | NA | YWxx (note) |
| XB6042M2S | 4.475±50mV | 4.30±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | NA | |
| XB6042Q2SV | 4.275±25mV | 4.075±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | 0.7 | |
| XB6042J2SV | 4.425±25mV | 4.25±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | 0.7 | |
| XB6042M2SV | 4.475±25mV | 4.30±50mV | 2.8±100mV | 3.0*±100mV | <0.1 | 0.7 | |

Note: 1)"YW" is manufacture date code, "Y" means the year, "W" means the week.

Note: If < 50 mAh Li-Battery is shorted, the voltage of battery maybe drop down to $0V\sim1V$ quickly so that the short-circuiting protection logic may not work properly. Increasing the value of resistor and capacitor can solve this problem, such as 1K and 1uF.

^{2) &}quot;xx" is internal product code of XySemi.

^{*:} Enter Sleep Mode after overdischarge, needs charging to activate normal discharge state

^{**:} Vsd-- Diode Forward Voltage when charging after overdischarge, Test Condition: V_{DD}=1.5V Ichar=40mA

PIN CONFIGURATION

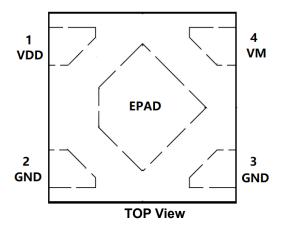


Figure 2. PIN Configuration

PIN DESCRIPTION

| XB6042 SERIES PIN NUMBER | PIN NAME | PIN DESCRIPTION |
|-----------------------------|----------|--|
| 1 | VDD | Power Supply |
| 2,3 | GND | Ground, connect the negative terminal of the battery to these pins. Please connect these pins with EPAD by mass metal. |
| 4 | VM | The internal FET switch connects this terminal to GND Please connect these pins by mass metal. |
| EPAD | NC | Not Use, Suggest to connect with GND (BAT-) |

ABSOLUTE MAXIMUM RATINGS

(Note: Do not exceed these limits to prevent damage to the device. Exposure to absolute maximum rating conditions for long periods may affect device reliability.)

| PARAMETER | VALUE | UNIT |
|--|------------|------|
| VDD input pin voltage | -0.3 to 6 | V |
| VM input pin voltage | -6 to 10 | V |
| Operating Ambient Temperature | -40 to 85 | °C |
| Maximum Junction Temperature | 150 | °C |
| Storage Temperature | -55 to 150 | °C |
| Lead Temperature (Soldering, 10 sec) | 300 | °C |
| Power Dissipation at T=25°C | 0.3 | W |
| Package Thermal Resistance (Junction to Ambient) θJA | 250 | °C/W |
| Package Thermal Resistance (Junction to Case) θυς | 130 | °C/W |

ELECTRICAL CHARACTERISTICS

Typicals and limits appearing in normal type apply for $T_A = 25^{\circ}C$, unless otherwise specified

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit | |
|--|----------------------|---|------|------|----------|------|--|
| Detection Current | | | L | | <u>I</u> | | |
| Overdischarge Current1 Detection | I _{IOV1} | V _{DD} =3.6V | 0.25 | 0.4 | 0.50 | А | |
| Overcharge Current Detection | I _{CHOC} | V _{DD} =3.6V | 0.25 | 0.4 | 0.50 | А | |
| Load Short-Circuiting Detection | *I _{SHORT} | V _{DD} =3.6V | 0.6 | 0.75 | 0.9 | Α | |
| Current Consumption | | | | | | | |
| Current Consumption in Normal Operation | I _{OPE} | V _{DD} =3.6V VM =0V | | 1.5 | 2.3 | μА | |
| Current Consumption in power Down (XB6042xxSx) | I _{PD} | V _{DD} =2.0V VM pin floating | | | 0.1 | μА | |
| Current Consumption in power Down (XB6042xxx) | I _{PD} | V _{DD} =2.0V VM pin floating | | 1.0 | 1.4 | μА | |
| VM Internal Resistance | | | | | | | |
| Internal Resistance between VM and V _{DD} | R _{VMD} | V _{DD} =2.0V VM pin floating | 200 | 300 | 400 | kΩ | |
| Internal Resistance between VM and GND | R _{VMS} | V _{DD} =3.6V VM=1.0V | 10 | 20 | 30 | kΩ | |
| FET on Resistance | | | | | | | |
| Equivalent FET on Resistance | *R _{DS(ON)} | V _{DD} =3.6V I _{VM} =0.2A | | 44 | | mΩ | |
| Over Temperature Protection | | | | | | | |
| Over Temperature Protection | *T _{SHD+} | | | 150 | | | |
| Over Temperature Recovery Degree | *T _{SHD-} | | | 110 | | - °C | |
| Detection Delay Time | | | | | | | |
| Overcharge Voltage Detection Delay Time | t _{CU} | | 80 | 170 | 240 | mS | |
| Overdischarge Voltage Detection Delay Time | t _{DL} | | 20 | 40 | 60 | mS | |
| Overdischarge Current 1 Detection Delay Time | t _{IOV1} | V _{DD} =3.6V | 5 | 10 | 20 | mS | |
| Overcharge Current Detection Delay Time | t _{CHOC} | V _{DD} =3.6V | 5 | 10 | 20 | mS | |
| Load Short-Circuiting Detection Delay Time | *t _{SHORT} | V _{DD} =3.6V | 80 | 180 | 300 | uS | |

Note1: * ---The parameter is guaranteed by design.

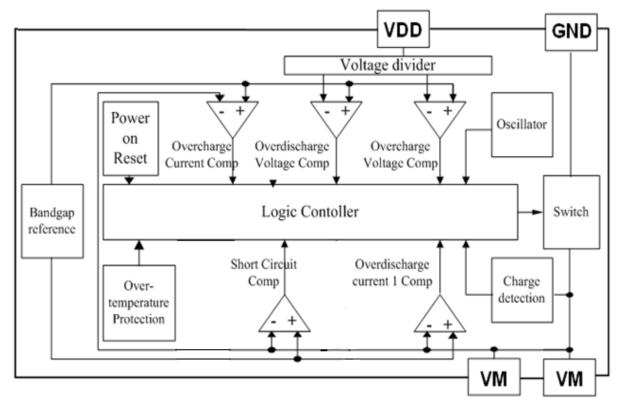


Figure 3. Functional Block Diagram

FUNCTIONAL DESCRIPTION

The XB6042 series monitors the voltage and current of a battery and protects it from being damaged due to overcharge voltage, overdischarge voltage, overdischarge current, and short circuit conditions by disconnecting the battery from the load or charger. These functions are required in order to operate the battery cell within specified limits.

The device requires only one external capacitor. The MOSFET is integrated and its $R_{DS(ON)}$ is as low as $44m\Omega$ typical.

Normal operating mode

If no exception condition is detected, charging and discharging can be carried out freely. This condition is called the normal operating mode.

Overcharge Condition

When the battery voltage becomes higher than the overcharge detection voltage (Vcu) during charging under normal condition and the state continues for the overcharge detection delay time (tcu) or longer, the XB6042 series turns the charging control FET off to stop charging. This condition is called the overcharge condition. The overcharge condition is released in the following two cases:

- 1, When the battery voltage drops below the overcharge release voltage (VcL), the XB6042 series turns the charging control FET on and returns to the normal condition.
- 2, When a load is connected and discharging starts, the XB6042 series turns the charging control FET on and returns to the normal condition. The release mechanism is as follows: the discharging

current flows through an internal parasitic diode of the charging FET immediately after a load is connected and discharging starts, and the VM pin voltage increases about 0.7 V (forward voltage of the diode) from the GND pin voltage momentarily. The XB6042 series detects this voltage and releases the overcharge condition. Consequently, in the case that the battery voltage is equal to or lower than the overcharge detection voltage (Vcu), the XB6042 series returns to the normal condition immediately, but in the case the battery voltage is higher than the overcharge detection voltage (Vcu), the chip does not return to the normal condition until the battery voltage drops below the overcharge detection voltage (Vcu) even if the load is connected. In addition, if the VM pin voltage is equal to or lower than the overcurrent detection voltage when a load is connected and discharging starts, the chip does not return to the normal condition.

Remark If the battery is charged to a voltage higher than the overcharge detection voltage (Vcu) and the battery voltage does not drops below the overcharge detection voltage (Vcu) even when a heavy load, which causes an overcurrent, is connected, the overcurrent do not work until the battery voltage drops below the overcharge detection voltage (Vcu). Since an actual battery has, however, an internal impedance of several dozens of m Ω , and the battery voltage drops immediately after a heavy load which causes an overcurrent is connected, the overcurrent work. Detection of load short-circuiting works regardless of the battery voltage.

Overdischarge Condition

When the battery voltage drops below the overdischarge detection voltage (V_{DL}) during discharging under normal condition and it continues for the overdischarge detection delay time (t_{DL}) or longer, the XB6042 series turns the discharging control FET off and stops discharging. This condition is called overdischarge condition.

After the discharging control FET is turned off, the VM pin is pulled up by the R_{VMD} resistor between VM and VDD in XB6042 series. Meanwhile when VM is bigger than 1.5V (typ.) (the load short-circuiting detection voltage), the current of the chip is reduced to the power-down current (I_{PDN}). This condition is called power-down condition. The VM and VDD pins are shorted by the R_{VMD} resistor in the IC under the overdischarge and power-down conditions.

The power-down condition is released when a charger is connected and the potential difference between VM and VDD becomes 1.3V (typ.) or higher (load short-circuiting detection voltage). At this time, the FET is still off. When the battery voltage becomes the overdischarge detection voltage (VDL) or higher (see note), the XB6042 series turns the FET on and changes to the normal condition from the overdischarge condition.

Remark If the VM pin voltage is no less than the charger detection voltage (VCHA), when the battery under overdischarge condition is connected to a charger, the overdischarge condition is released (the discharging control FET is turned on) as usual, provided that the battery voltage reaches the overdischarge release voltage (VDU) or higher.

Overcurrent Condition

When the discharging current becomes equal to or higher than a specified value (the VM pin voltage is equal to or higher than the overcurrent detection voltage) during discharging under normal condition and the state continues for the overcurrent detection delay time or longer, the XB6042 series turns off the discharging control FET to stop discharging. This condition is called overcurrent condition. (The overcurrent includes overcurrent, or load short-circuiting.)

The VM and GND pins are shorted internally by the R_{VMS} resistor under the overcurrent condition. When a load is

connected, the VM pin voltage equals the VDD voltage due to the load.

The overcurrent condition returns to the normal condition when the load is released and the impedance between the B+ and B-pins becomes higher than the automatic recoverable impedance. When the load is removed, the VM pin goes back to the GND potential since the VM pin is shorted the GND pin with the R_{VMS} resistor. Detecting that the VM pin potential is lower than the overcurrent detection voltage (V_{IOV1}), the IC returns to the normal condition.

Abnormal Charge Current Detection

If the VM pin voltage drops below the charger detection voltage (VcHA) during charging under the normal condition and it continues for the overcharge detection delay time (tcu) or longer, the XB6042 series turns the charging control FET off and stops charging. This action is called abnormal charge current detection. Abnormal charge current detection works when the discharging control FET is on and the VM pin voltage drops below the charger detection voltage (Vcha). When an abnormal charge current flows into a battery in the overdischarge condition, the XB6042 series consequently turns the charging control FET off and stops charging after the battery voltage becomes the overdischarge detection voltage and the overcharge detection delay time (tcu) elapses.

Abnormal charge current detection is released when the voltage difference between VM pin and GND pin becomes lower than the charger detection voltage (Vcha) by separating the charger. Since the 0 V battery charging function has higher priority than the abnormal charge current detection function, abnormal charge current may not be detected by the product with the 0 V battery charging function while

the battery voltage is low.

Load Short-circuiting condition

If voltage of VM pin is equal or below short circuiting protection voltage (V_{SHORT}), the XB6042 series will stop discharging and battery is disconnected from load. The maximum delay time to switch current off is t_{SHORT} . This status is released when voltage of VM pin is higher than short protection voltage (V_{SHORT}), such as when disconnecting the load.

Delay Circuits

The detection delay time for overdischarge current 2 and load short-circuiting starts when overdischarge current 1 is detected. As soon as overdischarge current 2 or load short-circuiting is detected over detection delay time for overdischarge current 2 or load short-circuiting, the XB6042 series stops discharging. When battery voltage falls below overdischarge detection voltage due to overdischarge current, the XB6042 series stop discharging by overdischarge current detection. In this case the recovery of battery voltage is so slow that if battery voltage after overdischarge voltage detection delay time is still lower than overdischarge detection voltage, the XB6042 series shifts to power-down.

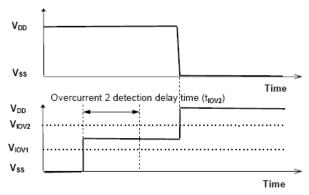


Figure 4. Overcurrent delay time

0V Battery Charging Function (1) (2) (3)

This function enables the charging of a connected battery whose voltage is 0 V by self-discharge. When a charger having 0 V battery start charging charger voltage (Vocha) or higher is connected between B+ and B- pins, the charging control FET gate is fixed to VDD potential. When the voltage between the gate and the source of the charging control FET becomes equal to or higher than the turn-on voltage by the charger voltage, the charging control FET is turned on to start charging. At this time, the discharging control FET is off and the charging current flows through the internal parasitic diode in the discharging control FET. If the battery voltage becomes equal to or higher than the overdischarge release voltage (VDU), the normal condition returns. **Note**

- (1) Some battery providers do not recommend charging of completely discharged batteries. Please refer to battery providers before the selection of 0 V battery charging function.
- (2) The 0V battery charging function has higher priority than the abnormal charge current detection function. Consequently, a product with the 0 V battery charging function charges a battery and abnormal charge current cannot be detected during the battery voltage is low (at most 1.8 V or lower).
- (3) When a battery is connected to the IC for the first time, the IC may not enter the normal condition in which discharging is possible. In this case, set the VM pin voltage equal to the GND voltage (short the VM and GND pins or connect a charger) to enter the normal condition.

TIMING CHART

1. Overcharge and overdischarge detection

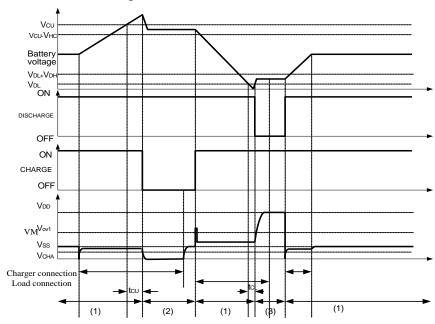


Figure 5-1 Overcharge and Overdischarge Voltage Detection

2. Overdischarge current detection

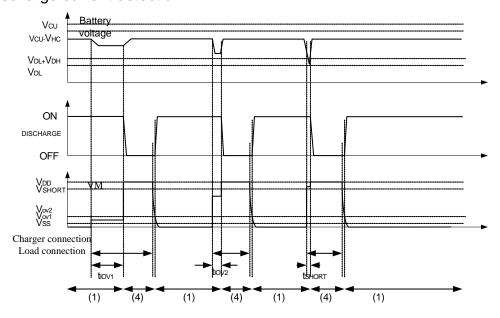


Figure5-2 Overdischarge Current Detection

Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition

3. Charger Detection

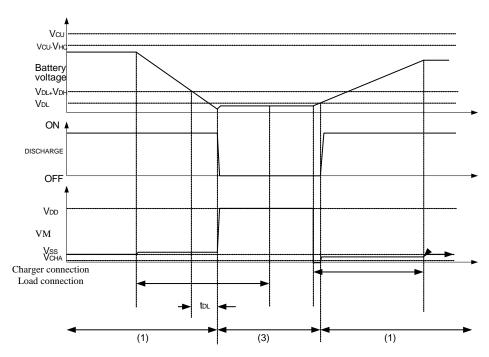


Figure 5-3 Charger Detection

4. Abnormal Charger Detection

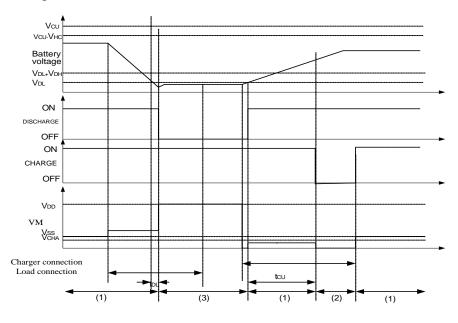


Figure 5-4 Abnormal Charger Detection

Remark: (1) Normal condition (2) Overcharge voltage condition (3) Overdischarge voltage condition (4) Overcurrent condition)

TYPICAL APPLICATION

As shown in Figure 6, the wide line is the high density current path which must be kept as short as possible, mass metal is better. For thermal management, ensure that these trace widths are adequate. C1& R1 is a decoupling capacitor & resistor which should be placed as close as possible to XB6042 series.

If add one 0.1uF capacitor between VM pin and GND pin closely, the system ESD level and anti-interference capability of circuit will improve greatly.

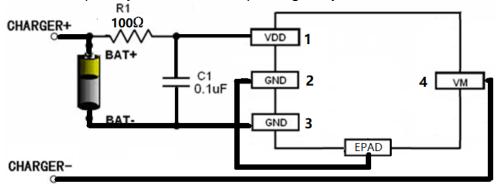


Fig 6 XB6042 series in a Typical Battery Protection Circuit

Precautions

- Pay attention to the operating conditions for input/output voltage and load current so that the power loss in XB6042 series does not exceed the power dissipation of the package.
- Do not apply an electrostatic discharge to this XB6042 series that exceeds the performance ratings of the built-in electrostatic protection circuit.
- If < 50 mAh Li-Battery is shorted, the voltage of battery maybe drop down to 0V~1V quickly so that the short-circuiting protection logic may not work properly. Increasing the value of resistor and capacitor can solve this problem, such as 1K and 1uF.

APPLIED MEASUREMENT METHOD

(4) Overala anno alcana eta nictio ta et moetla ele

(1). Overcharge characteristic test method:

- a. According to the figure 1, connect the power supply DC1 to the B + and GND pins of the system board and set the voltage to about 3.6V. Connect the power supply from GND to VM to DC2 power supply and set 100mV current limiting 10mA. Observe the waveform.
- b. Adjust the power supply voltage V1 and increase it by 0.001 V until the output level of VM pin changes from 0 to negative (- 100 mV). Record the overcharge protection voltage and measure the protection delay.
- c. Adjust the power supply voltage V1 to decrease by 0.001 V until the output voltage of VM pin is recovered from negative (- 100 mV) to 0 level, and record the overcharge recovery voltage.

(2). Over discharge characteristic test method:

- a. According to the figure 2, connect the power supply DC1 to the B + and GND pins of the system board and set the voltage to about 3.6V. Connect the DC2 power supply from VM to GND, set the 100mV current limiting 10mA, and observe the waveform.
- b. Adjust the power supply voltage V1 and increase it by 0.001V until the output level of VM pin changes from 0 to positive (100mV). Record the overcharge protection voltage and measure the protection delay.
- c. Adjust the power supply voltage V1 to decrease by 0.001 V until the output voltage of VM pin is restored from positive (100 mV) to 0 level, and record the overcharge recovery voltage.

(3).Discharge over current test method:

- a. According to the figure3, connect the DC1 power supply to the B + and GND pins of the system board and set the voltage to about 3.0V/3.6V/4.2V. Connect the electronic load from B + to VM and observe the waveform.
- b. Adjust the electronic load increase it by 0.1A step, detect that the current from B + to VM is turned off and meet the delay standard (about 10ms), and record the discharge delay time.

(4). Charging over current test method:

- a. According to the figure4, connect the DC1 power supply to the B + and GND pins of the system board and set the voltage to about 3.0V/3.6V/4.2V, and load DC2 power supply from GND to VM.
- b. Adjust the current limiting value of DC2 power supply to increase by 0.1A step, detect that the current from GND to VM is turned off and meet the delay standard(about 10ms), and record the charging over-current delay time.

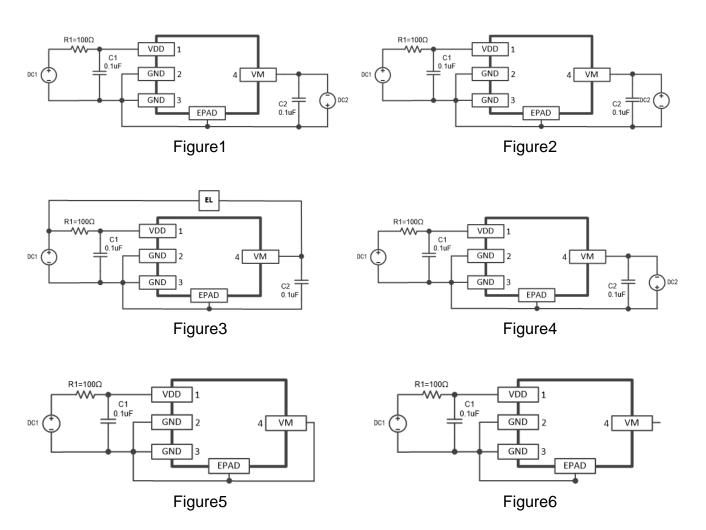
(5).lq test method:

- a. As shown in the figure5, connect the positive pole of DC1 to B +, and the negative pole to GND, and set the voltage to 3.6V;
- b. VM grounding, record the current passing through DC1 (Iq).

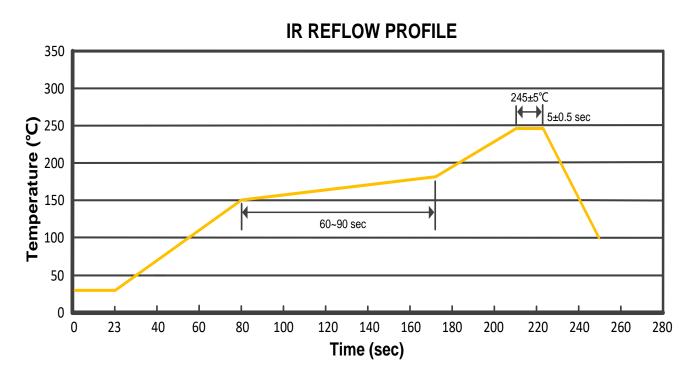
(6).lsd test method:

a. As shown in the figure6, connect the positive pole of DC1 to B + and the negative pole to GND, and set the voltage to 2V;

b. VM is suspended and the current passing through DC1 is recorded as Isd.



Solderability curve of lead-free reflow soldering (applicable to SMT tube)



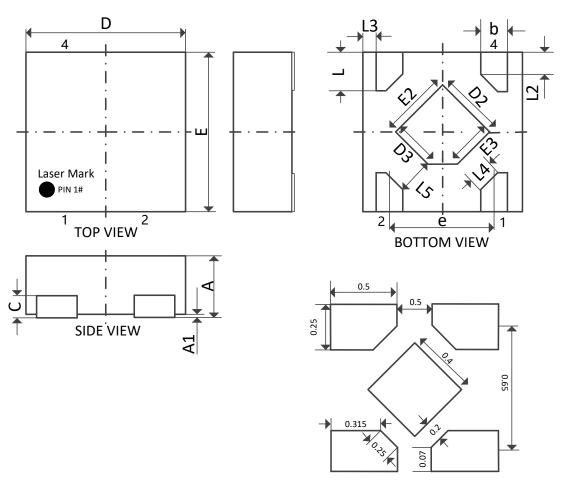
Explain:

- 1.Preheating temperature 25~150°C, duration 60~90sec;
- 2.Peak temperature 245 ± 5 °C, duration 5 ± 0.5 sec;
- 3.Cooling rate of welding process is 2~10°C/sec.

Resistance to welding heat conditions

Temperature: 270±5°C; Time:10±1sec

PACKAGE OUTLINE(DFN1X1X0.37-4)



RECOMMENDED LAND PATTERN uint(mm)

| 0.44501 | MILLIMETER | | | | |
|---------|------------|------|------|--|--|
| SYMBOL | MIN NOM | | MAX | | |
| А | 0.35 | - | 0.4 | | |
| A1 | 0.00 | 0.02 | 0.05 | | |
| b | 0.15 | 0.20 | 0.25 | | |
| С | 0.127REF | | | | |
| D | 0.95 | 1.00 | 1.05 | | |
| D2 | 0.38 | 0.48 | 0.58 | | |
| D3 | 0.23 | 0.33 | 0.43 | | |
| е | 0.65BSC | | | | |

| 0.44501 | MILLIMETER | | | | |
|---------|------------|------|------|--|--|
| SYMBOL | MIN | NOM | MAX | | |
| E | 0.95 | 1.00 | 1.05 | | |
| E2 | 0.38 | 0.48 | 0.58 | | |
| E3 | 0.23 | 0.33 | 0.43 | | |
| L | 0.20 | 0.25 | 0.30 | | |
| L2 | 0.103REF | | | | |
| L3 | 0.075REF | | | | |
| L4 | 0.208REF | | | | |
| L5 | 0.200REF | | | | |

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